Se	arch	Notes	

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/606,258	CHIN ET AL.	
Examiner	Art Unit	
Usmaan Saeed	2166	

	SEAR	CHED	
Class	Subclass	Date	Examiner
707 [°]	100, 104.1	8/13/2007	US
438	128, 129	8/13/2007	us
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INT	ERFERENC	CE SEARCH	ED
Class	Subclass	Date	Examiner
707	100, 104.	8/13/2007	US
438	128, 129	8/13/2007	US
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SEARCH N (INCLUDING SEARC)
	DATE	EXMR
Updated (East	8/7/2007	us
Consulted Primary Examiner (Khanh Pham)	8/7/2007	US
Consulted SPE (Hosain Alam)	8/7/2007	US
Consulted Primary Examiner (Leslie Wong)	8/8/2007	us